

- 1.Requirements
- 2.Description of selected chips
- 3.MAROC implementation
- 4.MAROC Binary output tests

# Frontend Electronics

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CLAS12 RICH Technical Review, 2013 June 26-27

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# Requirements (for PMT readout)



<b>Single PhotoElectron Sensitivity</b>	~50 fC
Number of channels	25600/sector
MAPMT anodes gain spread compensation	1:4
<b>Event Rate</b>	20kHz
Dead Time	few%
CLAS12 trigger latency	8 $\mu$ s
<b>Time resolution</b>	~1 ns
to disentangle direct and reflected photons (can be done off line)	
<b>Positive HV anodes</b>	reduce PMT electrostatic interference and noise
Electronics needs to be able to comple with positive HV anodes	

# Choice of the Electronics

- On-the-shelf components (no brand new development)
- Fulfill the requirements
- High channel density
- Existing expertise in the collaboration



VMM1/FermiLab

CLARO/INFN

APV25/CMS

**DREAM/JLAB**

**MAROC/LAL**

non consolidated , interesting specs

early stage, few channels

not enough latency

CLAS12 Micromegas

ATLAS Luminometer

# DREAM asic

## Dead-timeless Readout Electronics Asic for Micromegas



Single Channel (x64) - Design for Micromegas @ CLAS12

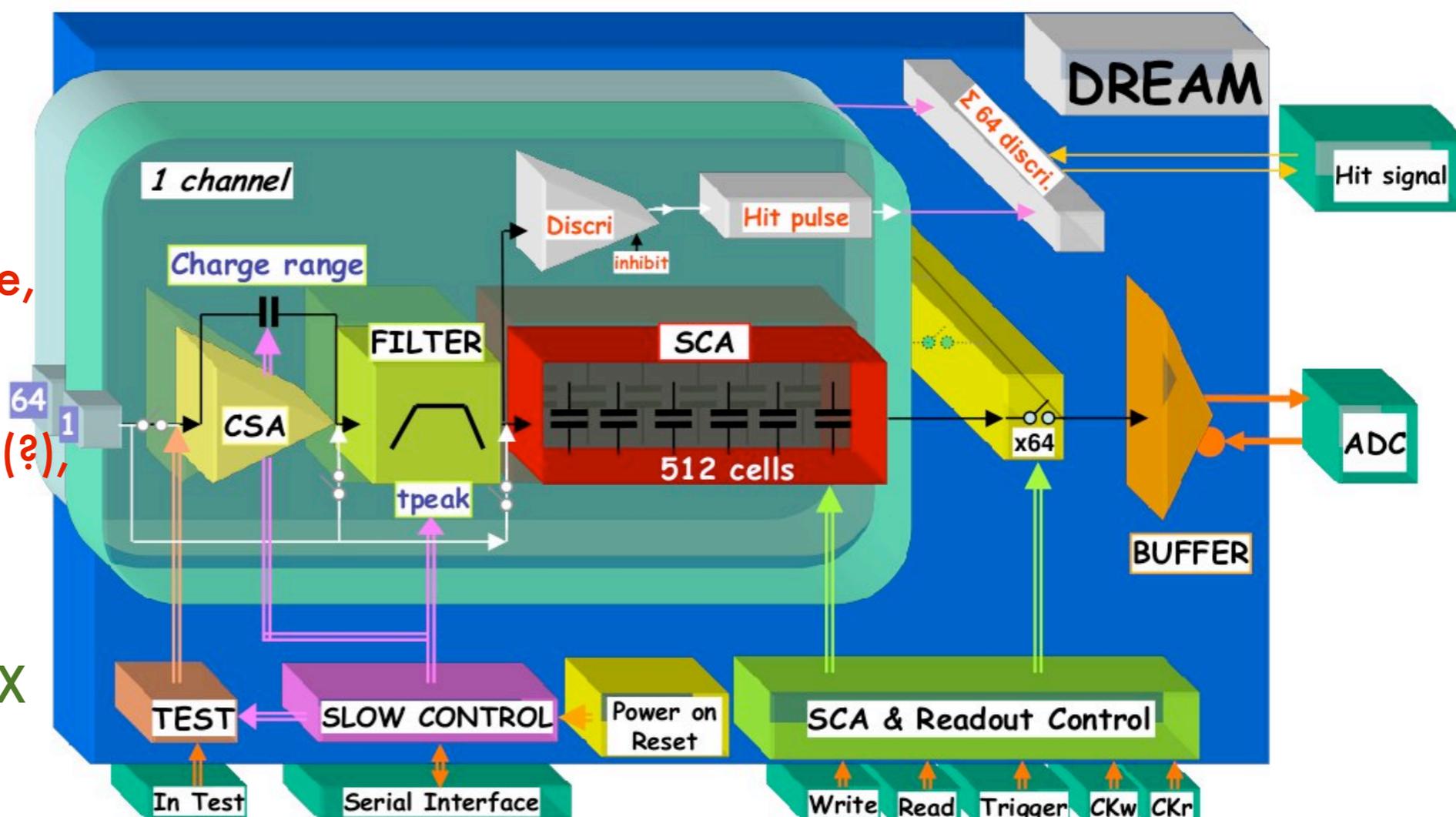
- Preamplifier, adj gain on 4 ranges (60fC, 120fC, 240fC, 1pC)
- Shaper, adj peaking time 16 values from 50 ns to 1  $\mu$ s
- Analog memory 512 cells, sampling rate 1-50MHz
- Discriminator, trigger pipeline 16  $\mu$ s, sum of 64

- 140-pin
- 0.4mm package,
- 17mm x17 mm footprint

**PROs:** analog pipeline,  
designed for JLAB12

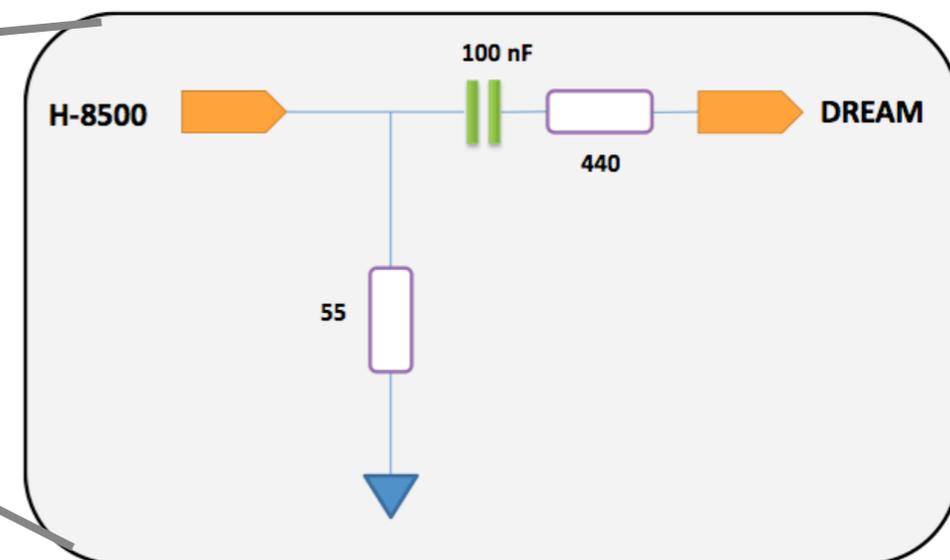
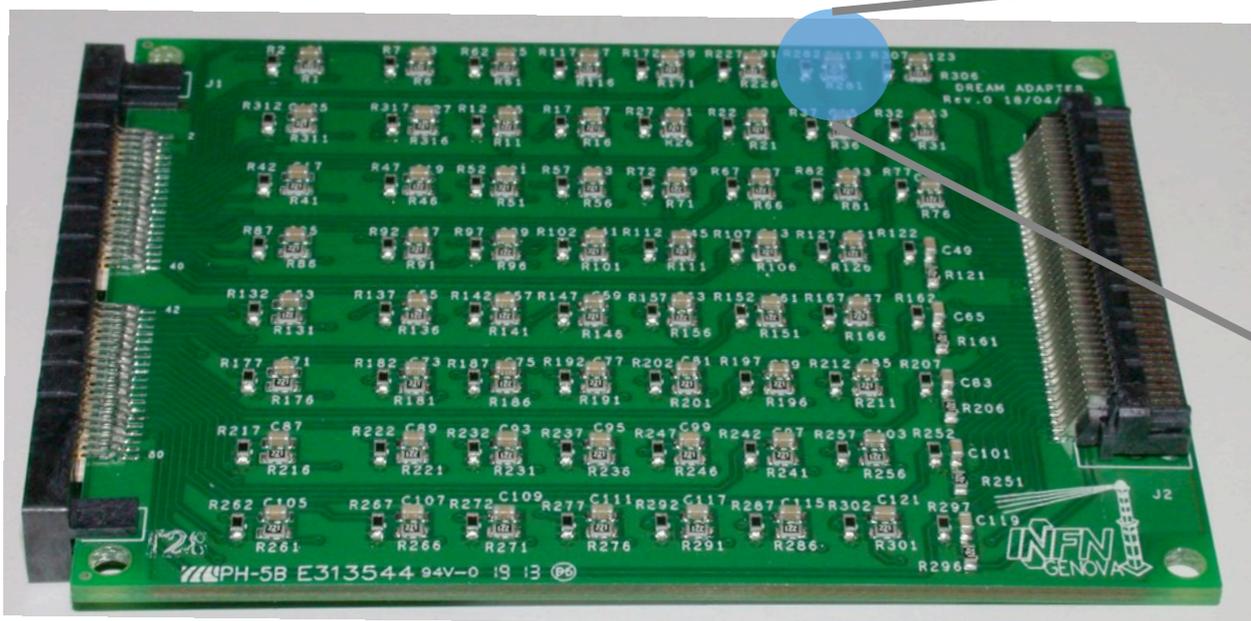
**CONs:** dynamic range (?),  
time resolution.

**Output:** Analog MUX  
and Digital Sum



# PMT DREAM interface

Dead-timeless Readout Electronics Asic for Micromegas  
R&D from Micromegas group

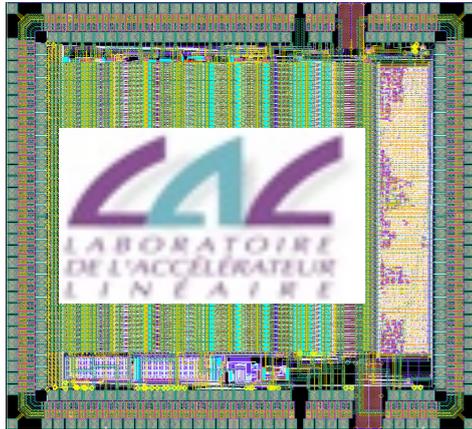


Attenuation board for H8500  
with various divider ratio for testing

TEST SCHEDULED 2013 JULY at INFN-FRASCATI

# MAROC asic

## Multi Anode Read Out Chip



- 240-pin
- 16 mm<sup>2</sup>

**PROs:** Designed for MAPMT apps, existing expertise

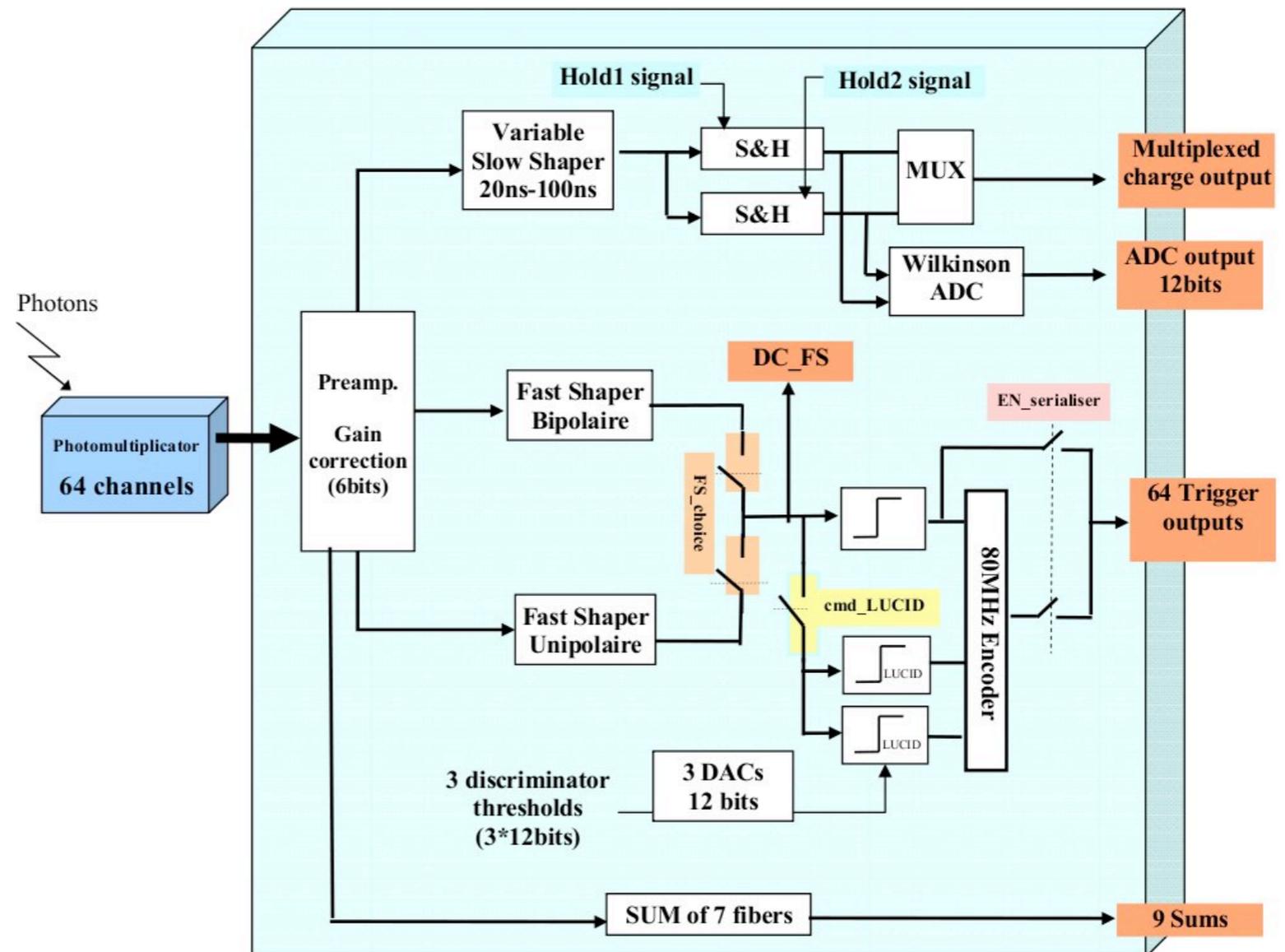
**CONs:** limited latency, time resolution

**Output:** Analog MUX and Digital parallel

### Single Channel (x64)

- Preamplifier, adj gain 8 bit
- Fast Shaper (25 ns) + Discriminator
- Slow Shaper (100 ns) + Internal ADC

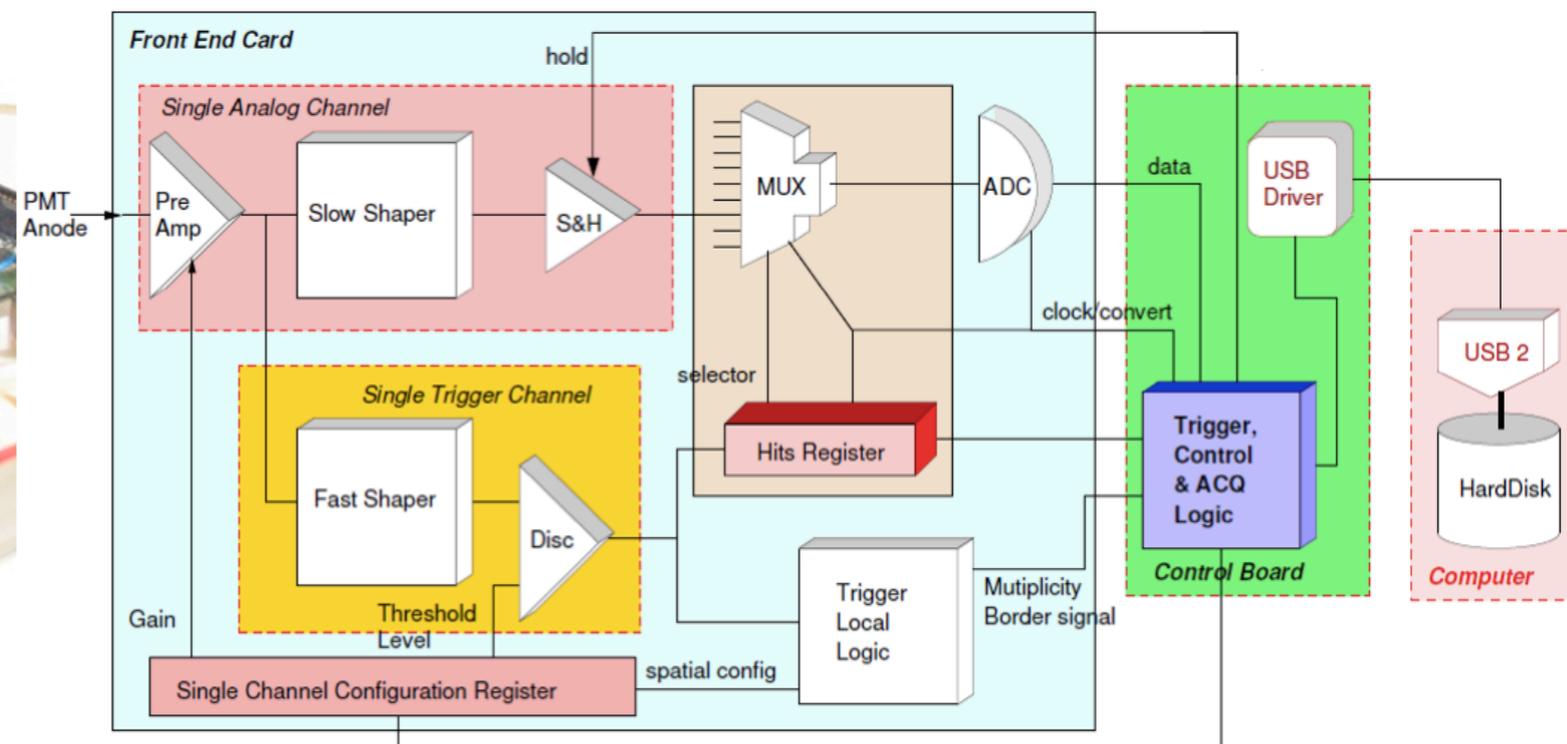
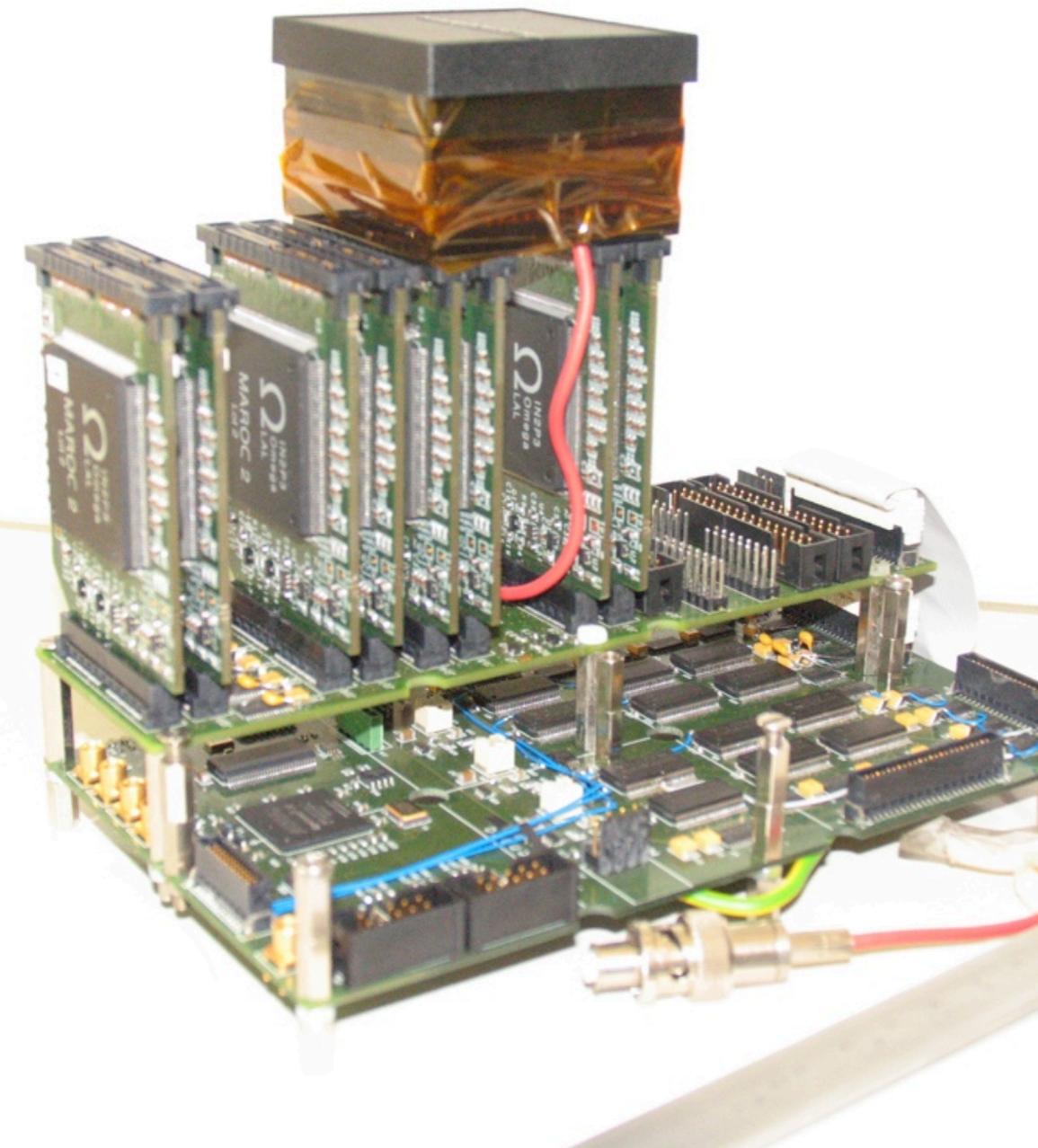
Originally designed for ATLAS



# In House MAROC based DAQ

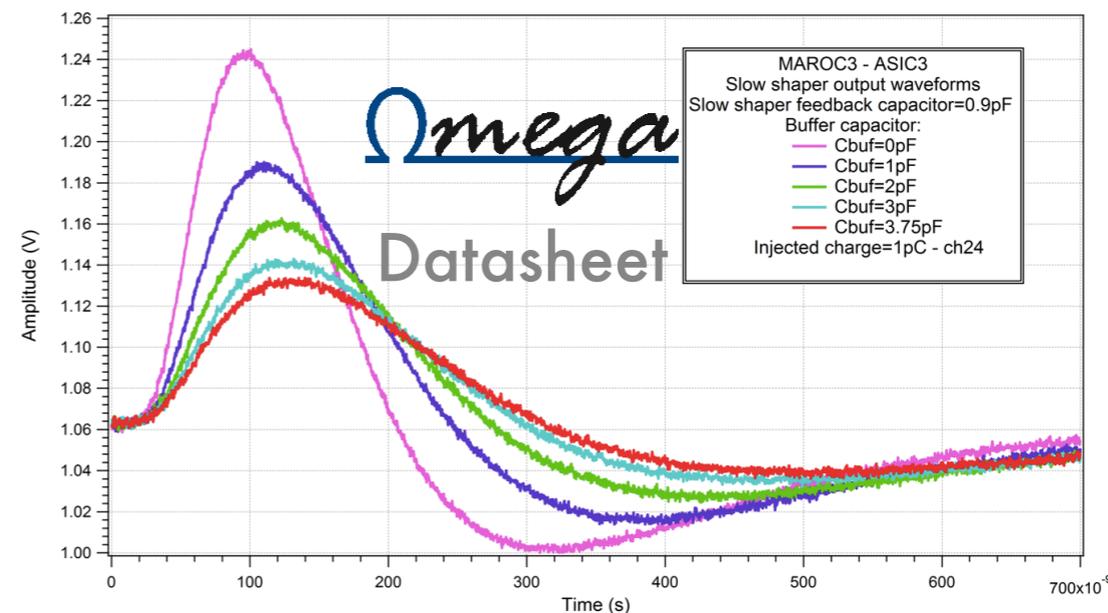
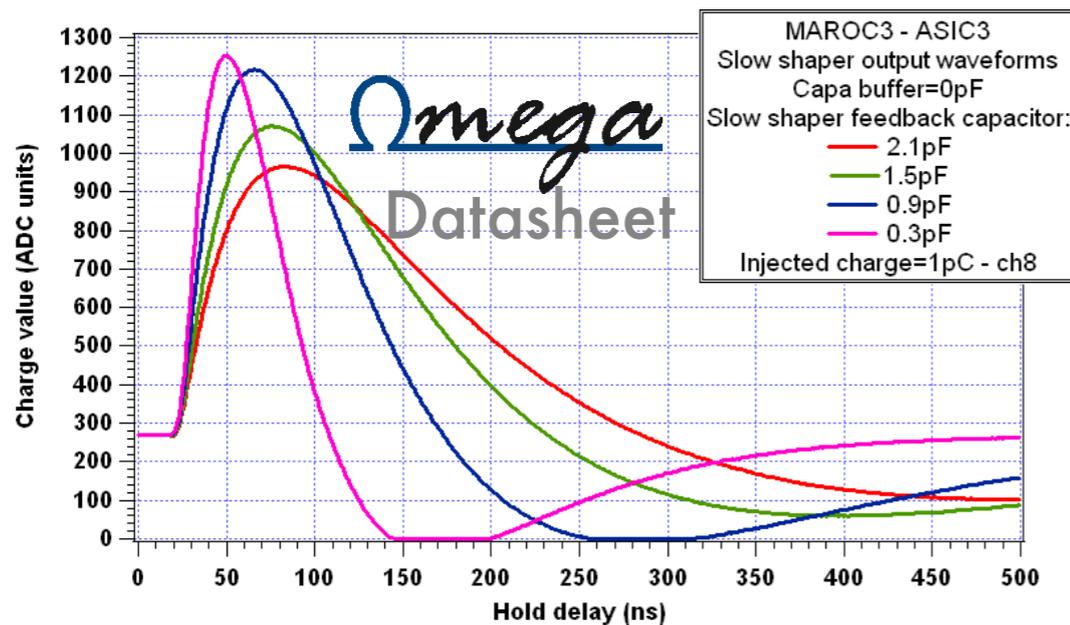
Original system developed for Radionuclides Imaging System  
4096 Channels  
Many optical photons  
Binary output used for self trigger

**Not Optimized for Single Photon**



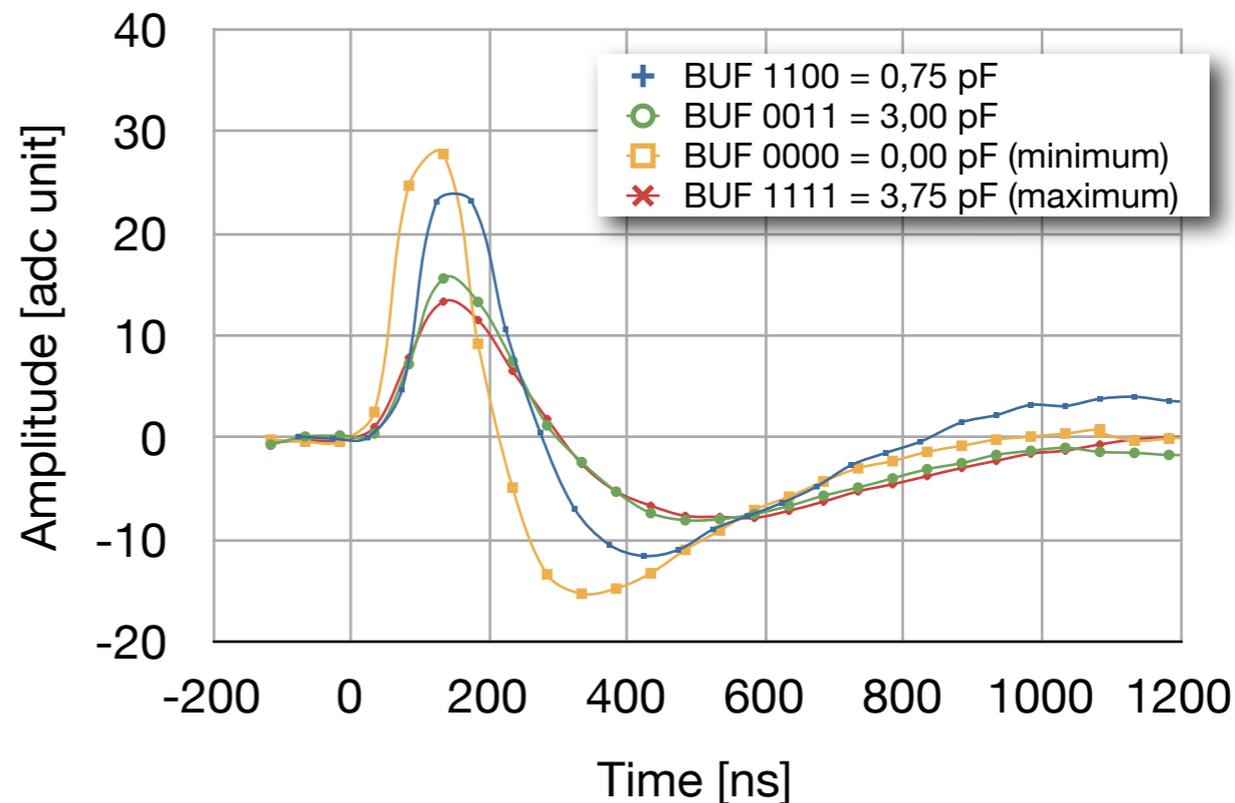
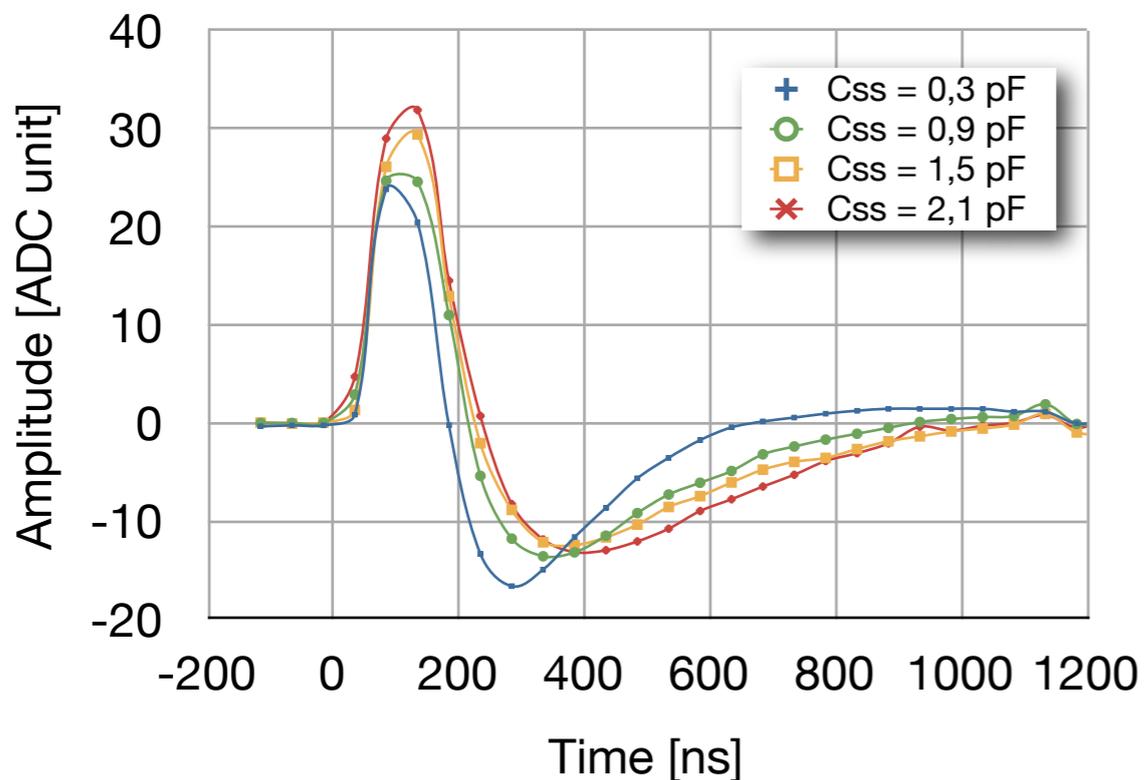
Adopted for the RICH prototype in analog output mode

# Reproduce MAROC specs



Slow Channel Pulses CBUF = 0 pF

Slow Channel Pulses C<sub>ss</sub> = 0.9 pF



Well reproduced but different output range (partially known)

# MAROC from Analog to Binary

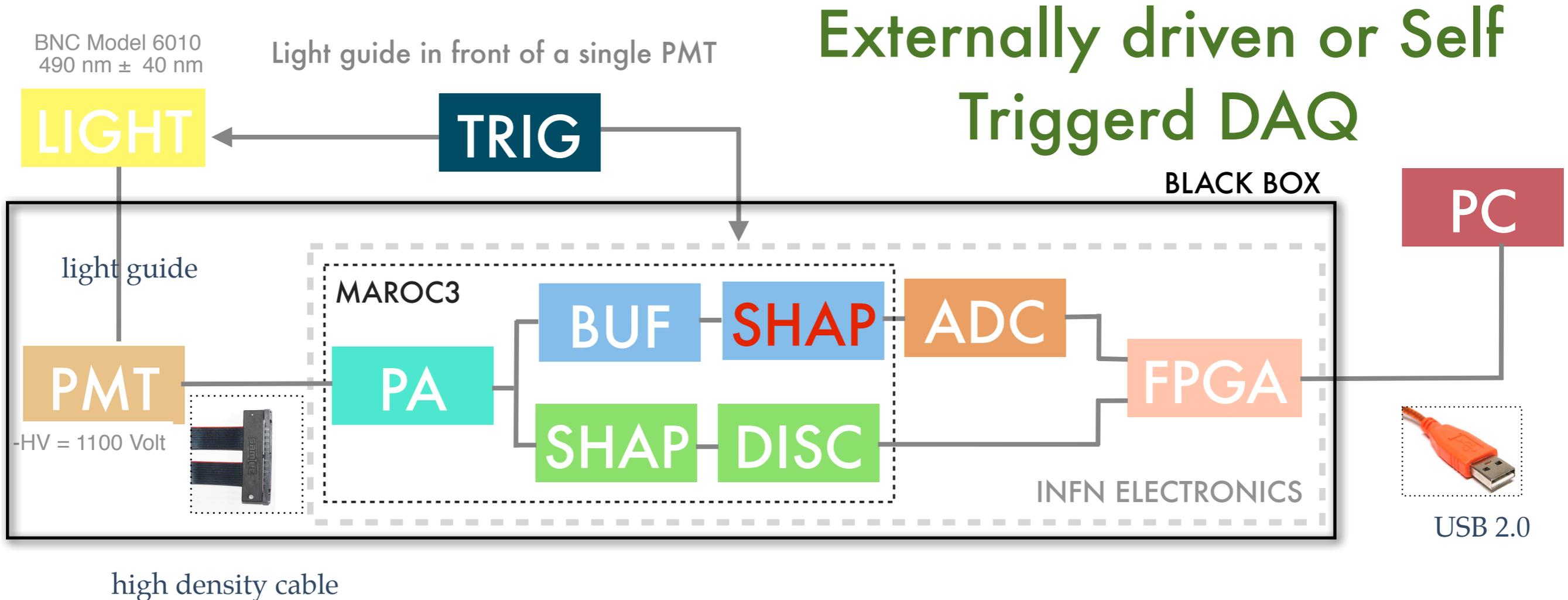
MAROC analog output works pretty well in RICH prototype test, but cannot be use in CLAS12 due to limited latency (200 ns)

MAROC binary information (64 parallel outputs) can be a valid alternative

see talk by Benjamin Raydo

- ▶ Binary data latency depends on external logic! **Feasible**
- ▶ Stability/sensitivity of threshold to single photoelectron? **Tested**
- ▶ Noise in MAROC fast shaper? **Measured**
- ▶ Implemented electronics not optimized for binary readout with external trigger (need significant FIRMWARE revision) **Postponed**

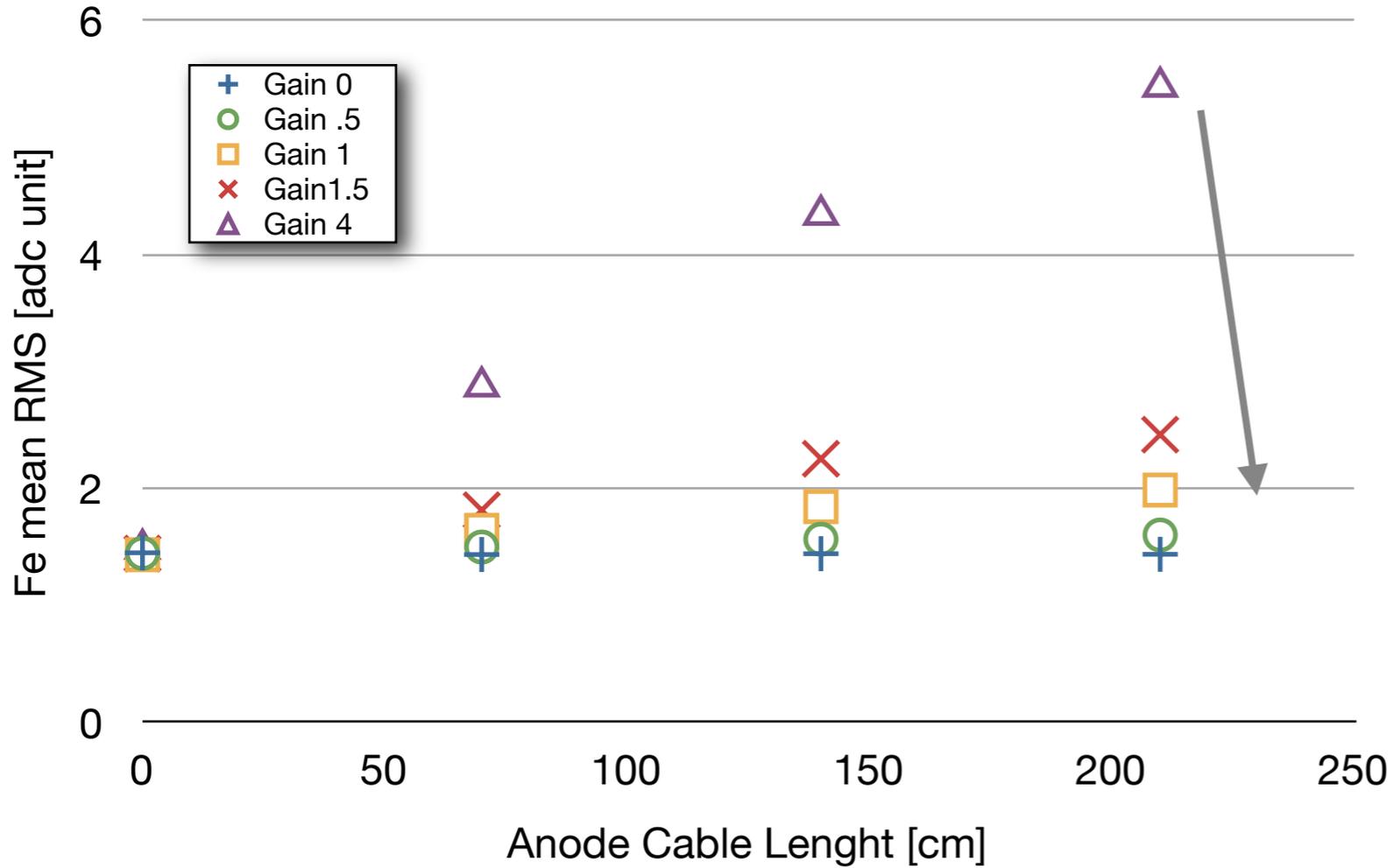
# Light Test Setup



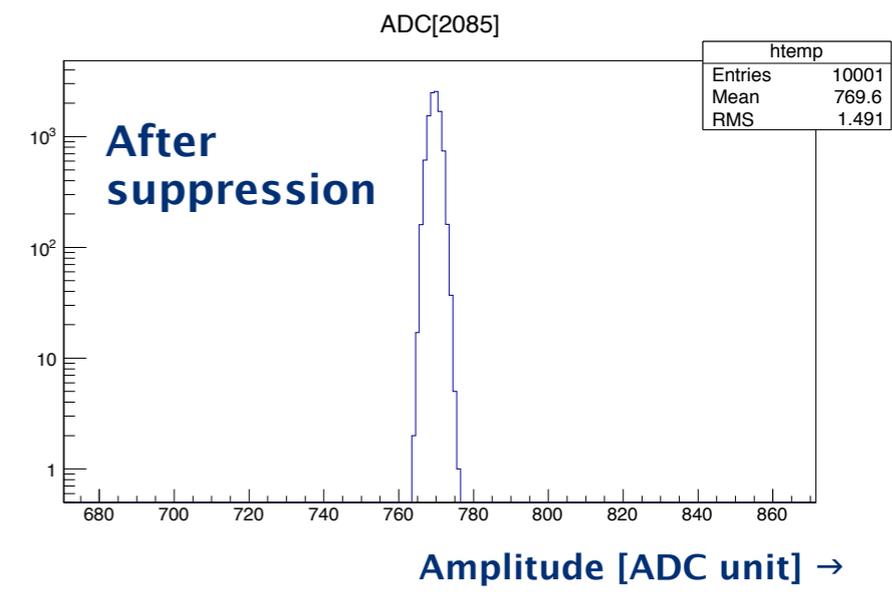
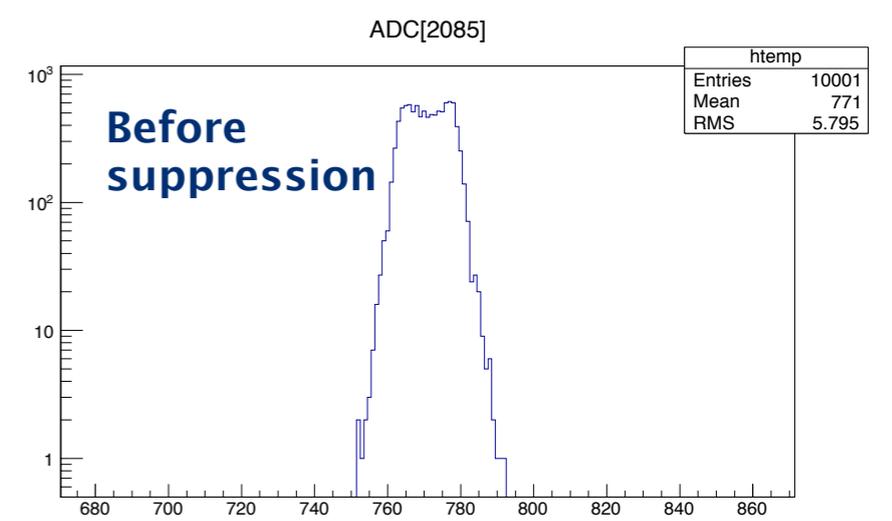
- Assume analog output as reference
- Measure "digital" noise with PMT on, no light (and other configurations)
- Compare/Correlate analog and binary information, with internal and external (need synch) triggers
- Measure range (in threshold) of the ~single photon signal by threshold scan to estimate SNR

# MAROC Analog Noise

## Noise vs PMT-Ele Cable length



Common noise **suppressed offline** significantly reduce the pedestal RMS

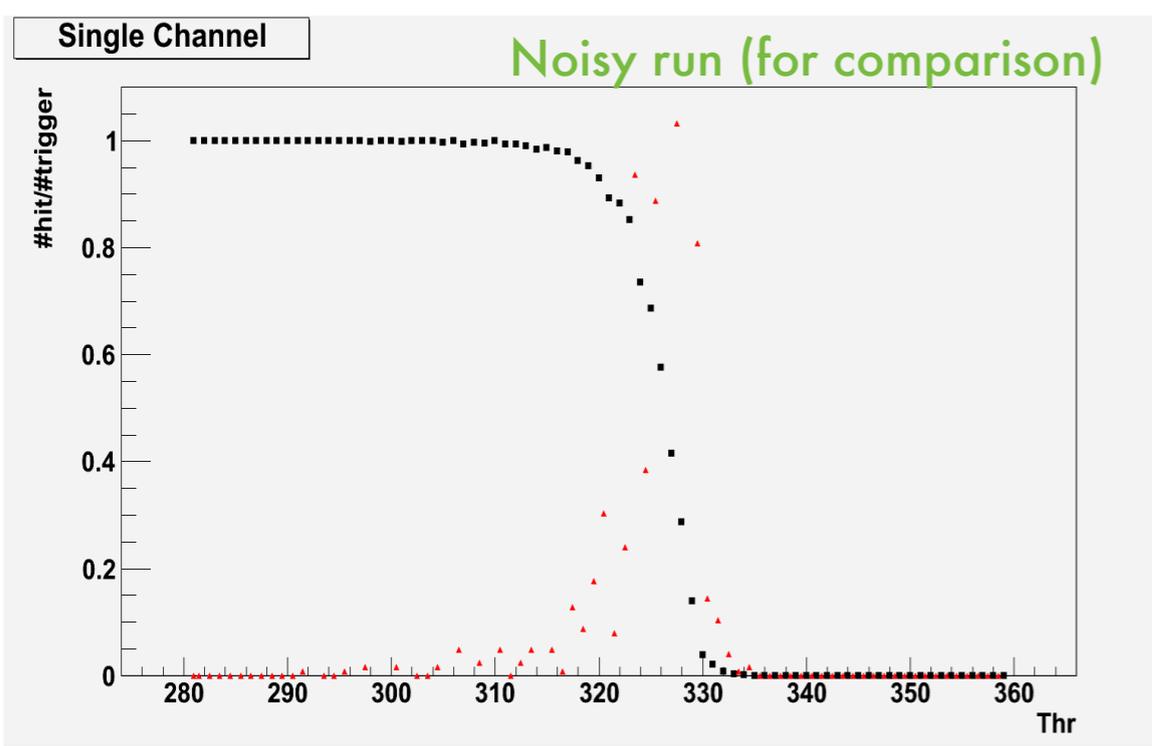
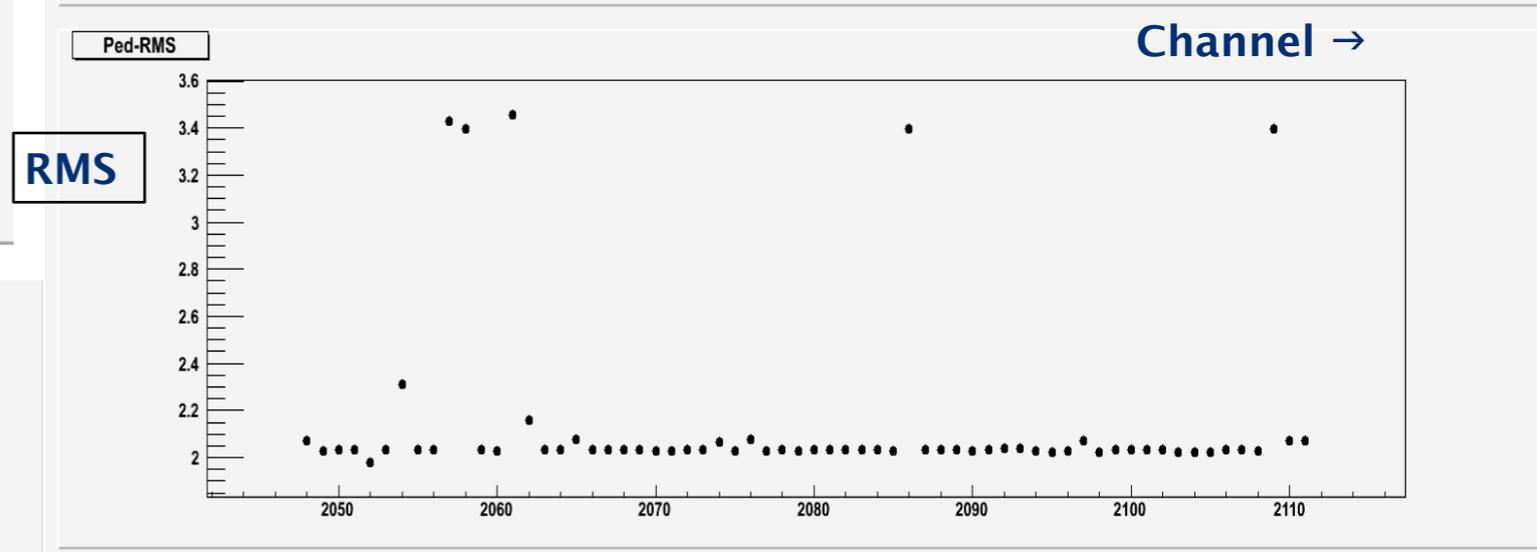
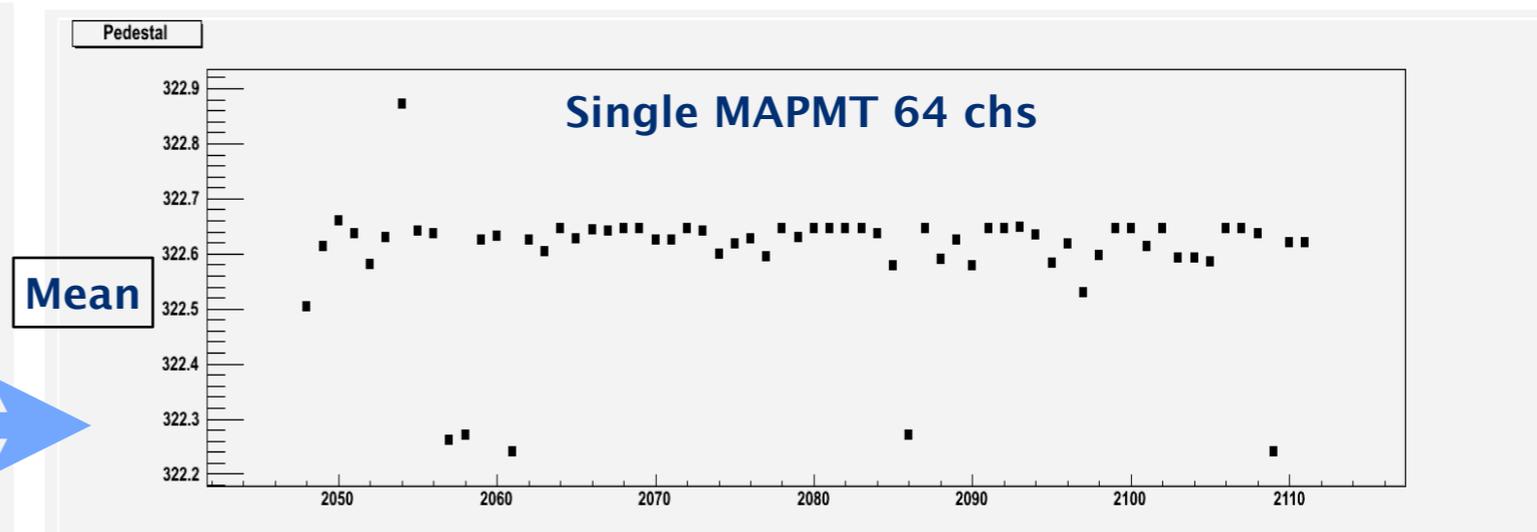
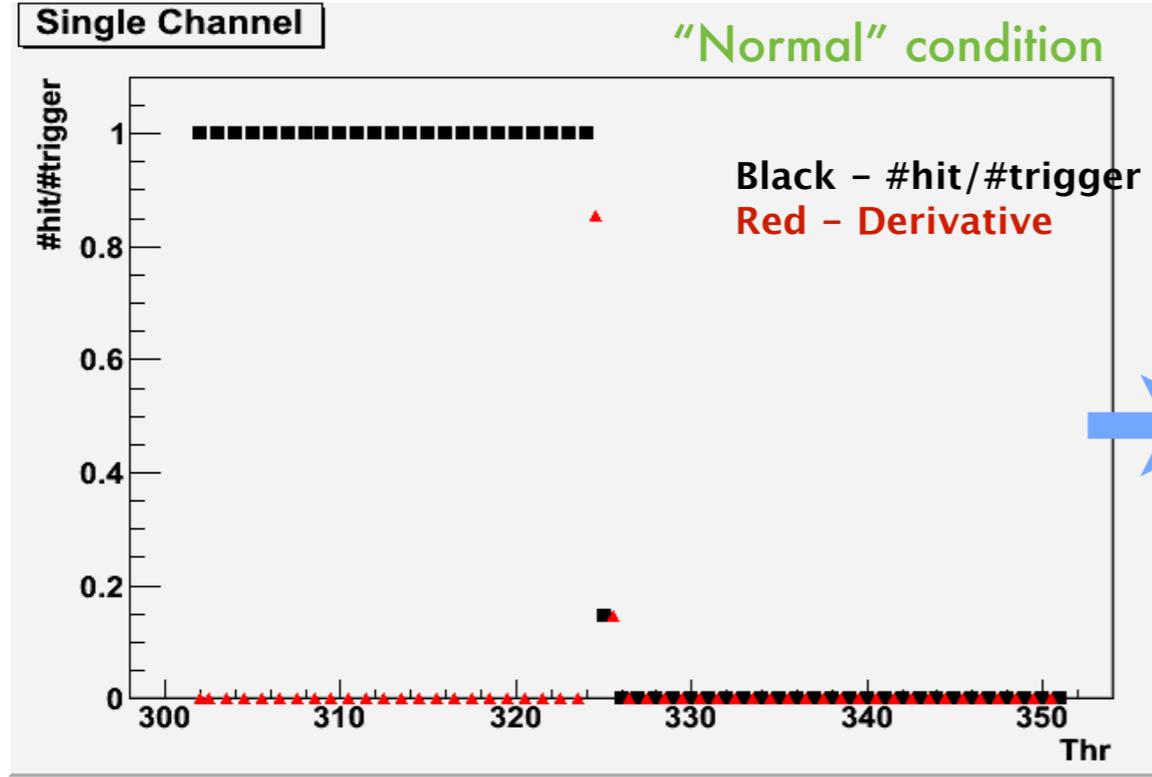


Most of the noise seems to come from **COMMON NOISE**

Noise conditions are site dependent!

# MAROC Digital Noise

Binary pedestal as derivative of the "hit efficiency" threshold scan

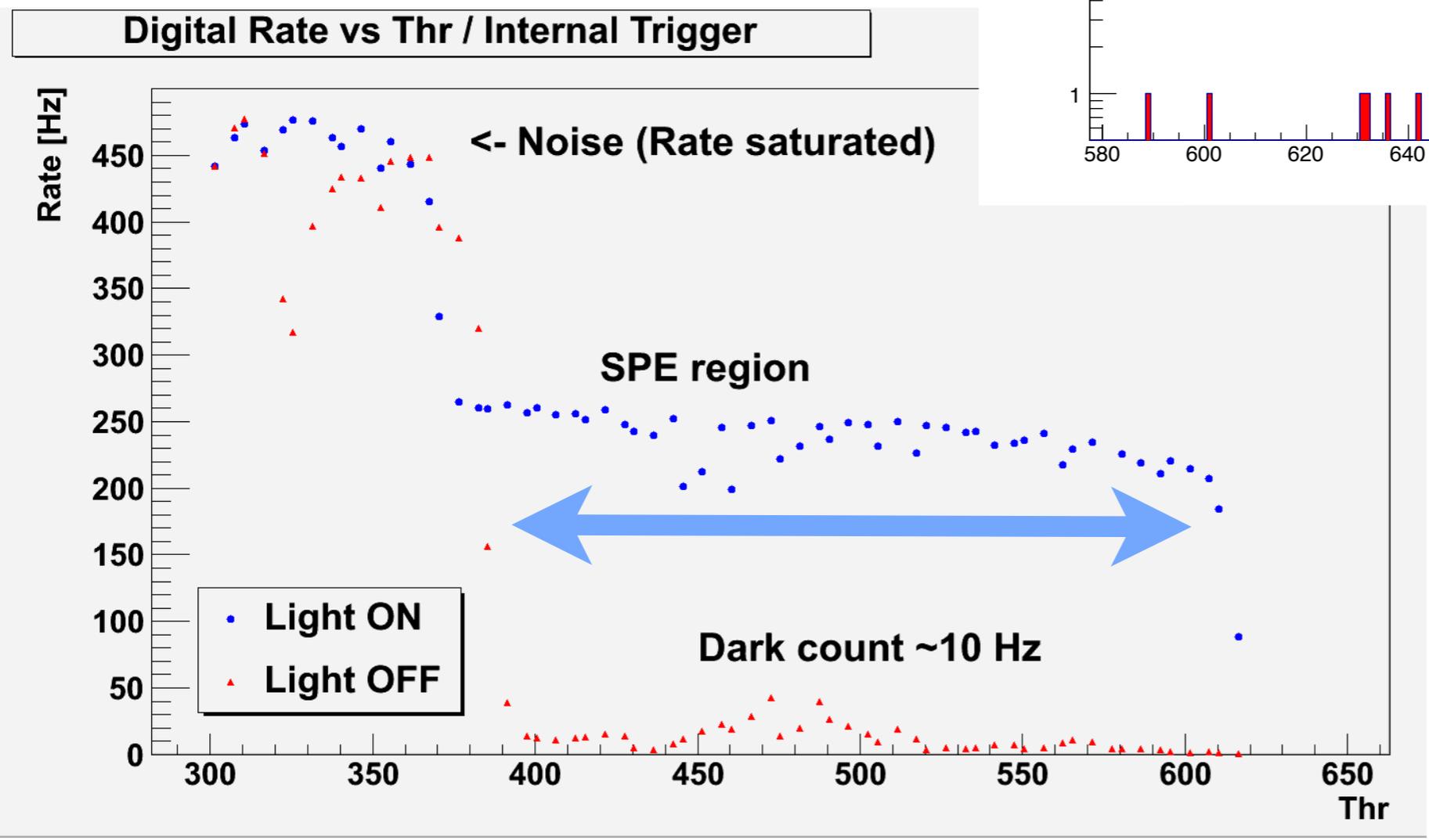
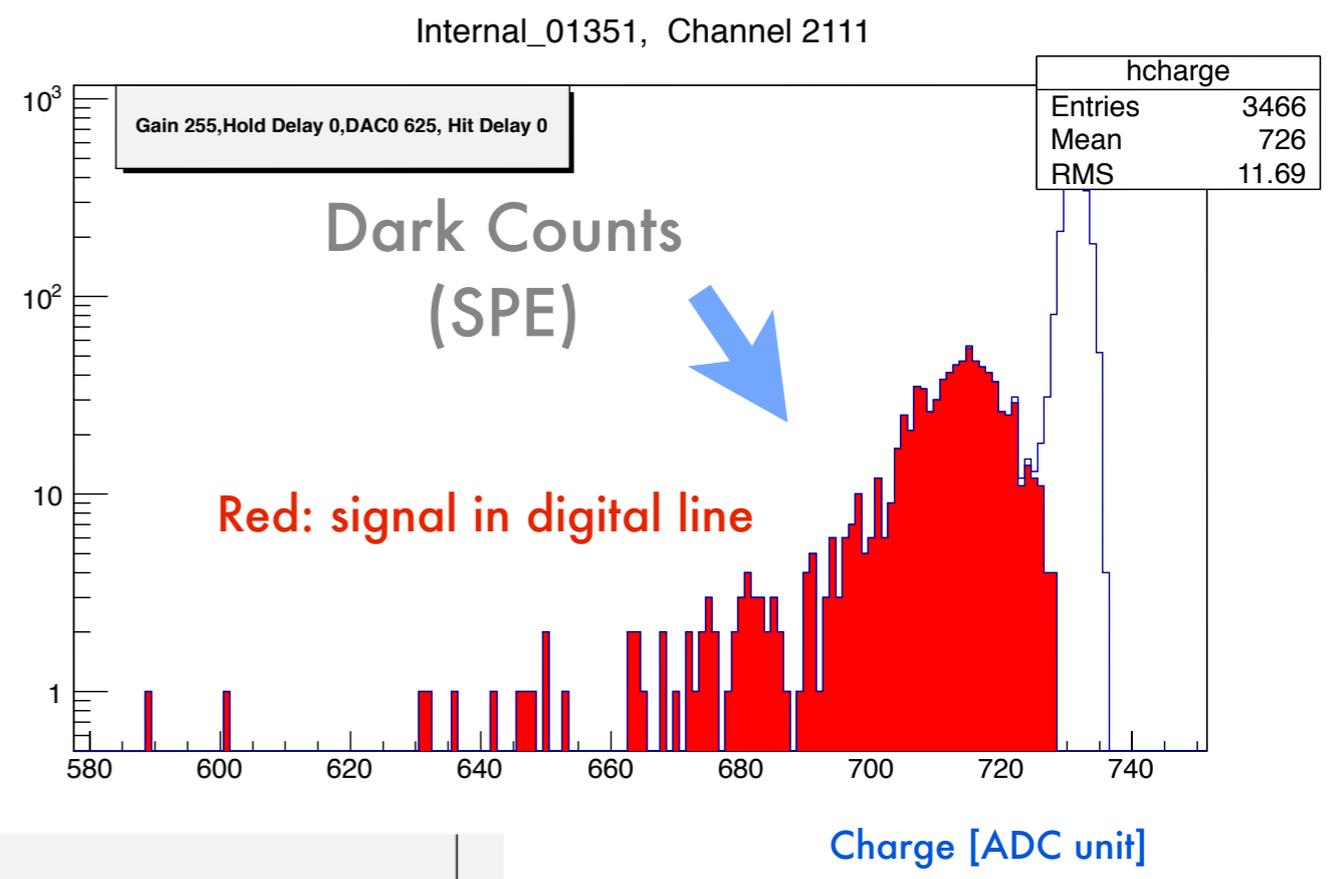


**=> Digital RMS < 1 thr unit (< 3mV)**  
 Analog Pedestal RMS 3-5 ADC unit (2-4 mV)  
 Digital/Analog comparable => see next for SNR  
 Noise uniformity vs channel

# Dark Noise and SPE

## Internal trigger

SPE region extent over ~200 thr unit  
(compare with Ped\_RMS < 1)



Pretty sharp cut => clean SPE binary identification

# Single PhotoElectron Level

## External trigger / Light Source

The CLAS12 running conditions  
(but MAROC electronics not optimized!)

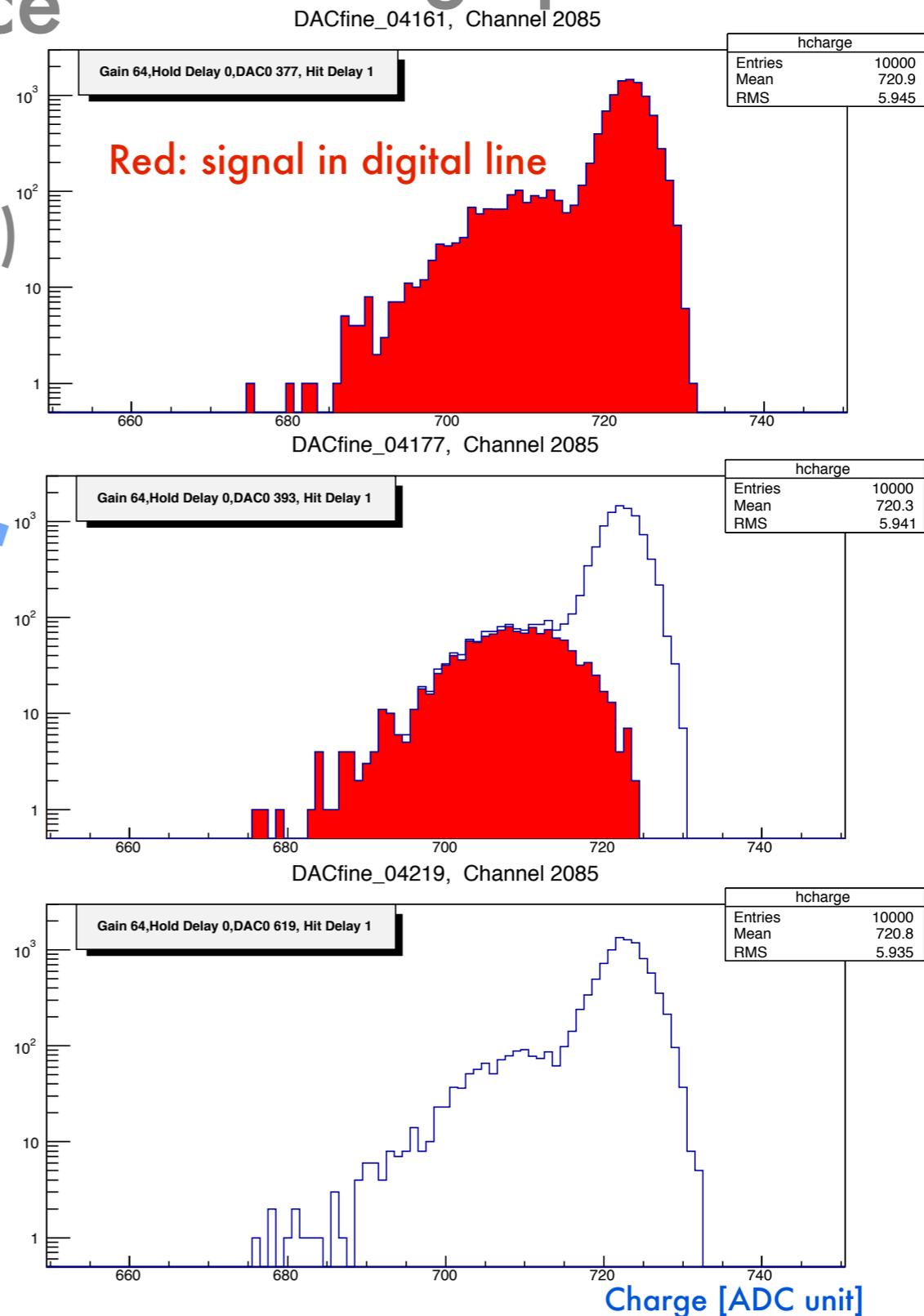
## Clean SPE identification with digital threshold

Smooth cut due to:

- Light source jitter (60 ns)
- Analog and digital lines are not optimally sync (~25 ns offset)
- Noise in digital line (small effect according to previous slides)

Common noise not subtracted

## Analog spectra



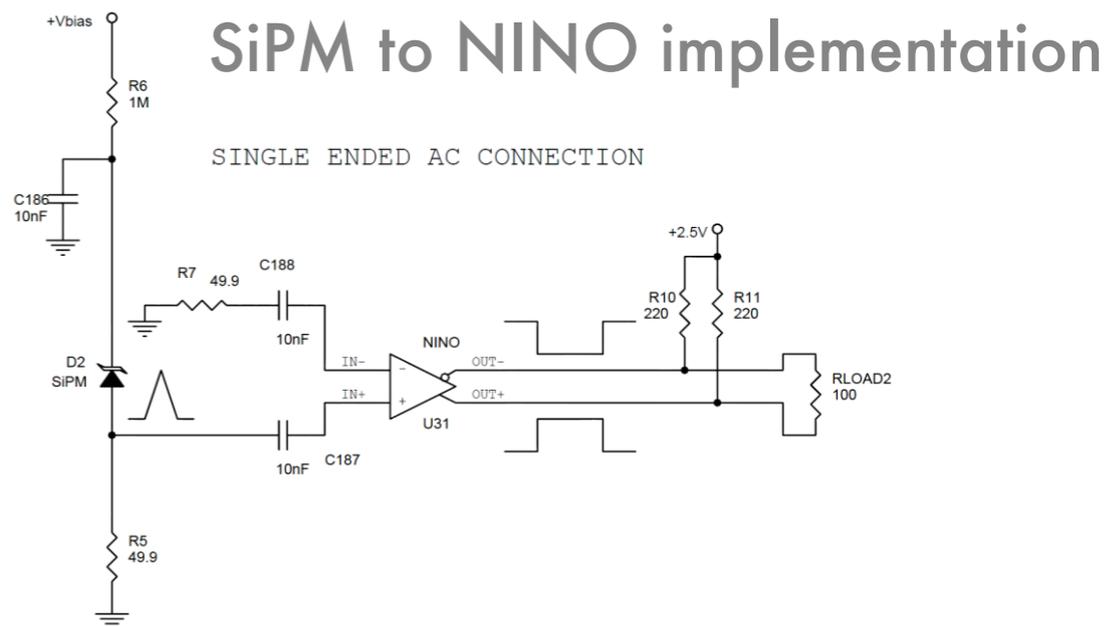
# Expertise in SiPM readout

NINO : ultra fast, low power, amplifier and discriminator for TOF (ALICE)

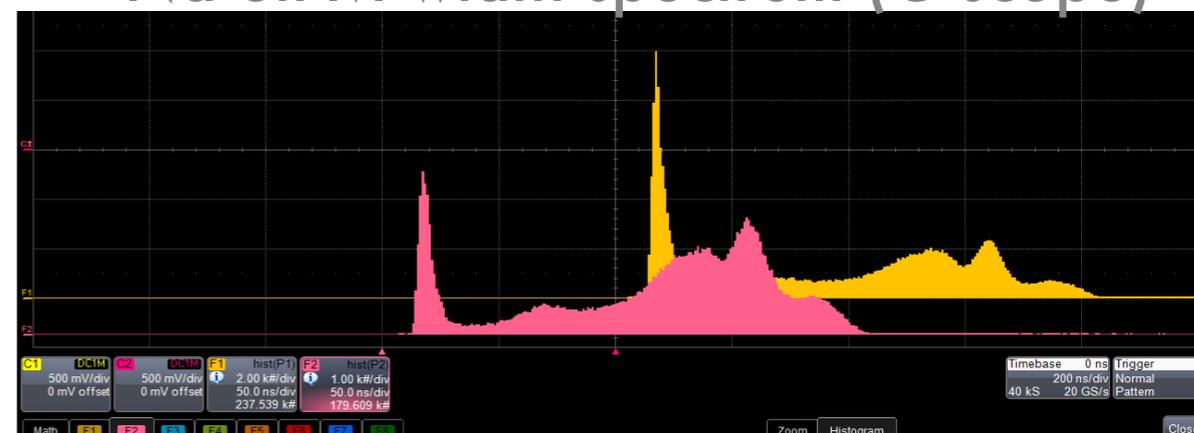
Use of NINO chip as a preamp in precise time measurement with SiPM (TOF-PET application)

Could be extended to SiPM for RICH

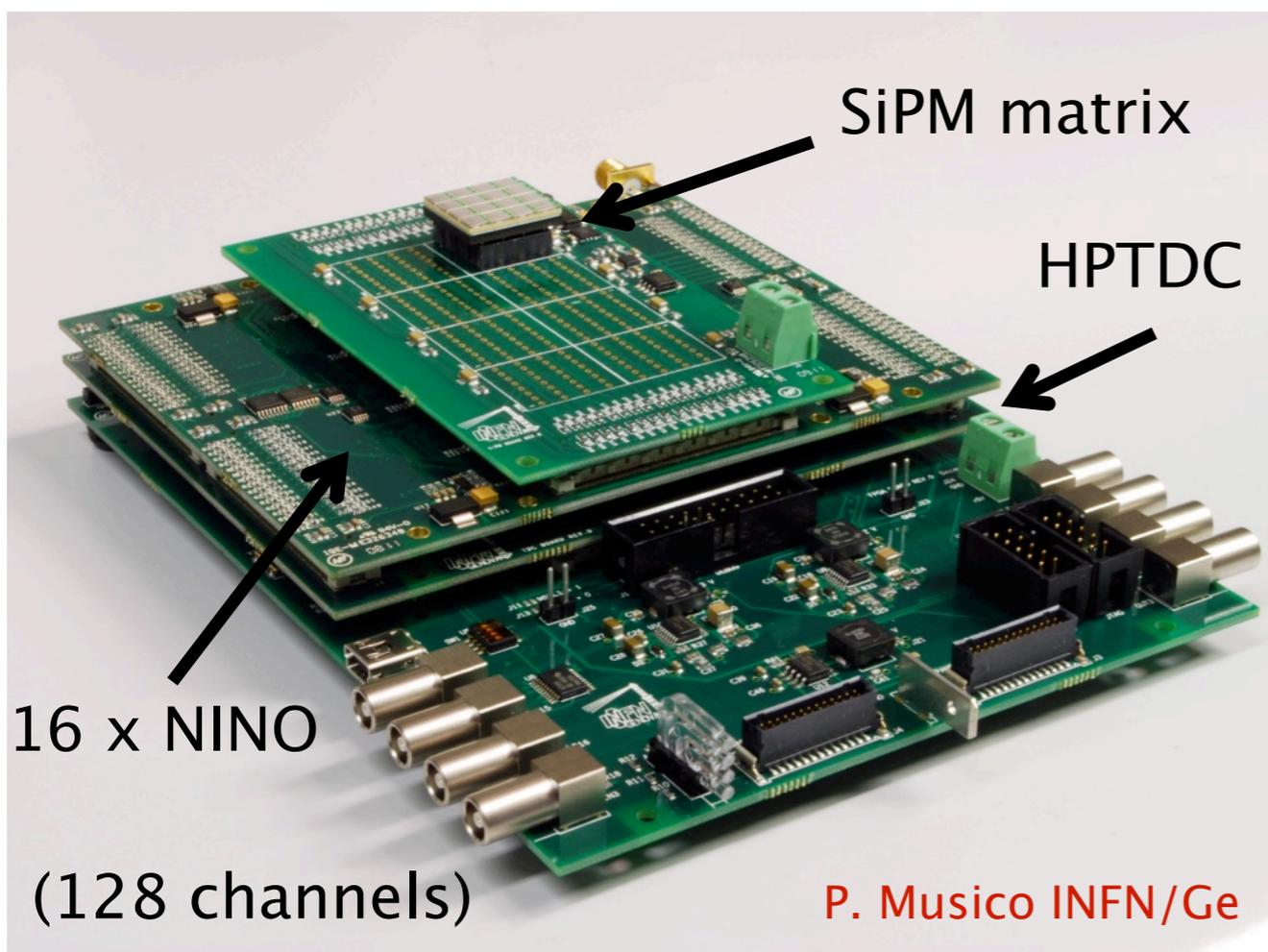
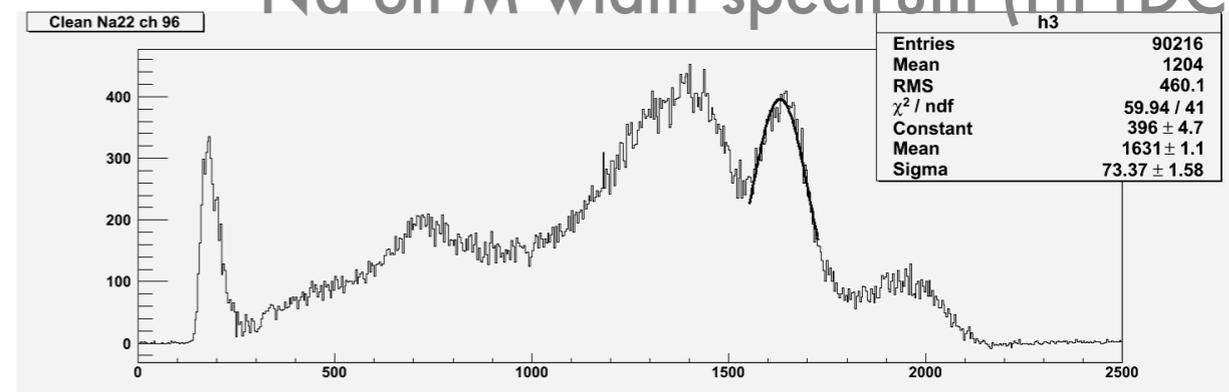
More integrated solutions to be considered



$^{22}\text{Na}$  SiPM width spectrum (O-scope)



$^{22}\text{Na}$  SiPM width spectrum (HPTDC)



# Conclusion

Two candidate solutions for the RICH readout based either on MAROC or on DREAM

## MAROC

- Must work in binary mode (analog for calibration only)
- binary mode suitable for single photoelectron detectability
- existing implementation can be adapted to CLAS12: SSP in place of the current controller will likely minimize the work to be done

## DREAM

- Provide multisample analog information
- no needs of additional development for JLab integration
- coupling to PMT must be proved (test in july)

**Electronics Test in July** on DREAM and MAROC  
Detailed design once the chip has been defined

**End**

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